

High speed series fifth generation

High speed 5 IGBT in TRENCHSTOP™ 5 technology copacked with full-rated RAPID 1 fast and soft antiparallel diode

### Features and Benefits:

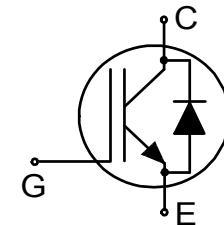
- High speed H5 technology offering
- Best-in-Class efficiency in hard switching and resonant topologies
- Plug and play replacement of previous generation IGBTs
- 650V breakdown voltage
- Low gate charge  $Q_G$
- IGBT copacked with full-rated RAPID 1 fast and soft antiparallel diode
- Maximum junction temperature 175°C
- Qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models:  
<http://www.infineon.com/igbt/>

### Applications:

- Uninterruptible power supplies
- Solar converters
- Welding converters
- Mid to high range switching frequency converters

### Package pin definition:

- Pin 1 - gate
- Pin 2 & backside - collector
- Pin 3 - emitter



### Key Performance and Package Parameters

Type	$V_{CE}$	$I_C$	$V_{CEsat}, T_{vj}=25^\circ C$	$T_{vjmax}$	Marking	Package
IKW75N65EH5	650V	75A	1.65V	175°C	K75EEH5	PG-T0247-3

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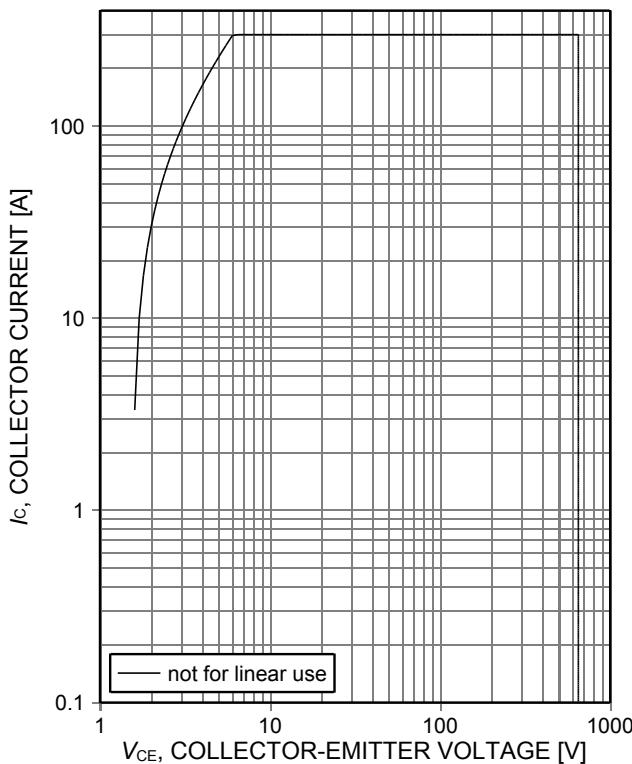


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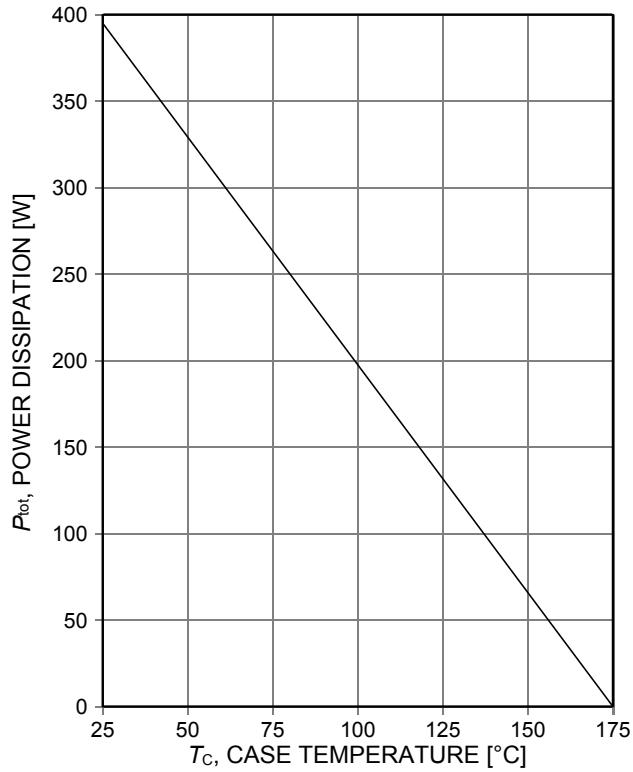
Diode Characteristic, at  $T_{vj} = 150^\circ\text{C}$ 

Diode reverse recovery time	$t_{rr}$	$T_{vj} = 150^\circ\text{C}$ , $V_R = 400\text{V}$ , $I_F = 75.0\text{A}$ , $di_F/dt = 1000\text{A}/\mu\text{s}$ , $L\sigma = 30\text{nH}$ , $C\sigma = 25\text{pF}$	-	123	-	ns
Diode reverse recovery charge	$Q_{rr}$		-	3.70	-	$\mu\text{C}$
Diode peak reverse recovery current	$I_{rrm}$		-	43.8	-	A
Diode peak rate of fall of reverse recovery current during $t_b$	$di_{rr}/dt$		-	-2000	-	$\text{A}/\mu\text{s}$
Diode reverse recovery time	$t_{rr}$	$T_{vj} = 150^\circ\text{C}$ , $V_R = 400\text{V}$ , $I_F = 37.5\text{A}$ , $di_F/dt = 1000\text{A}/\mu\text{s}$ , $L\sigma = 30\text{nH}$ , $C\sigma = 25\text{pF}$	-	108	-	ns
Diode reverse recovery charge	$Q_{rr}$		-	2.70	-	$\mu\text{C}$
Diode peak reverse recovery current	$I_{rrm}$		-	38.7	-	A
Diode peak rate of fall of reverse recovery current during $t_b$	$di_{rr}/dt$		-	-1050	-	$\text{A}/\mu\text{s}$

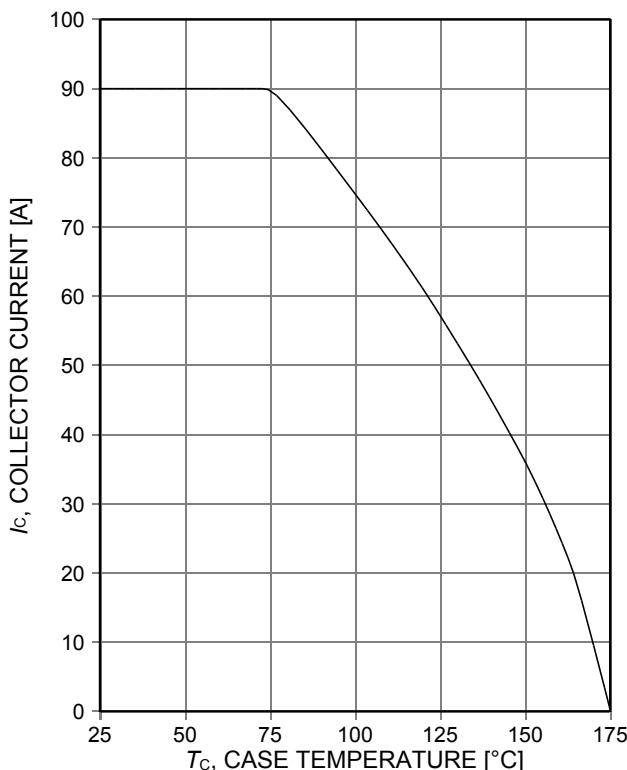
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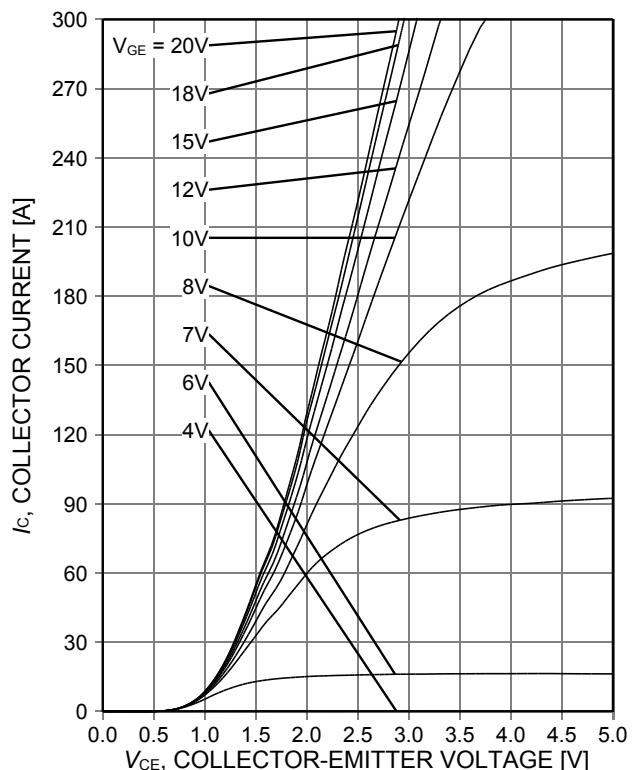
**Figure 1. Forward bias safe operating area**  
 $(D=0, T_C=25^\circ\text{C}, T_{vj}\leq 175^\circ\text{C}, V_{GE}=15\text{V}, t_p=1\mu\text{s}, I_{Cmax} \text{ defined by design - not subject to production test})$



**Figure 2. Power dissipation as a function of case temperature**  
 $(T_{vj}\leq 175^\circ\text{C})$



**Figure 3. Collector current as a function of case temperature**  
 $(V_{GE}\geq 15\text{V}, T_{vj}\leq 175^\circ\text{C})$



**Figure 4. Typical output characteristic**  
 $(T_{vj}=25^\circ\text{C})$

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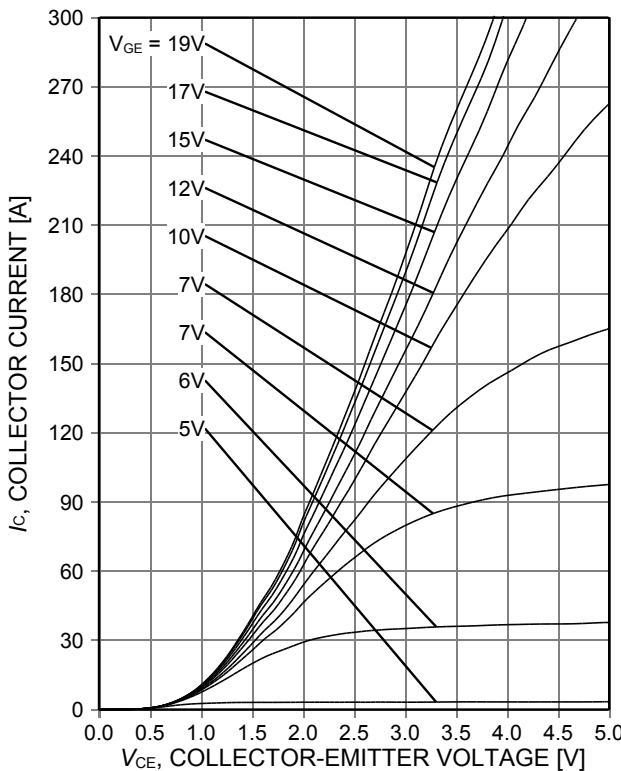


Figure 5. Typical output characteristic  
( $T_{vj}=150^{\circ}\text{C}$ )

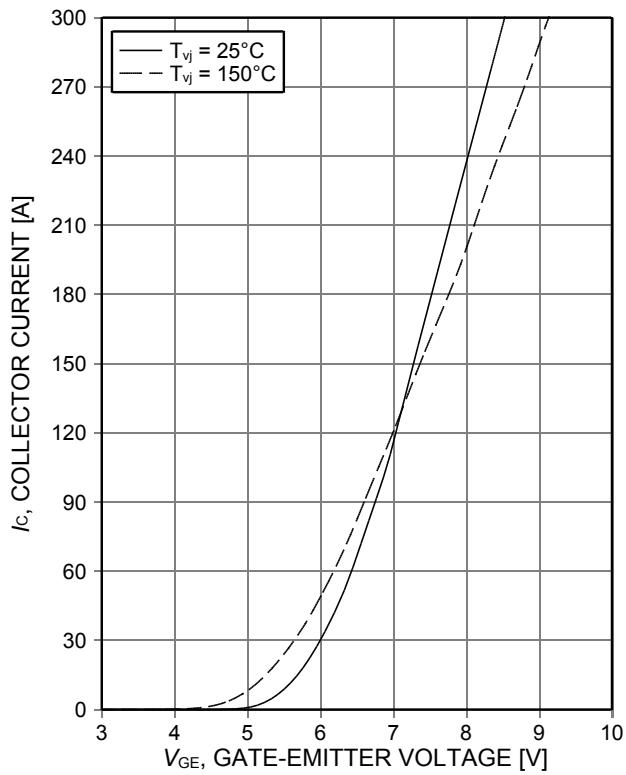


Figure 6. Typical transfer characteristic  
( $V_{CE}=20\text{V}$ )

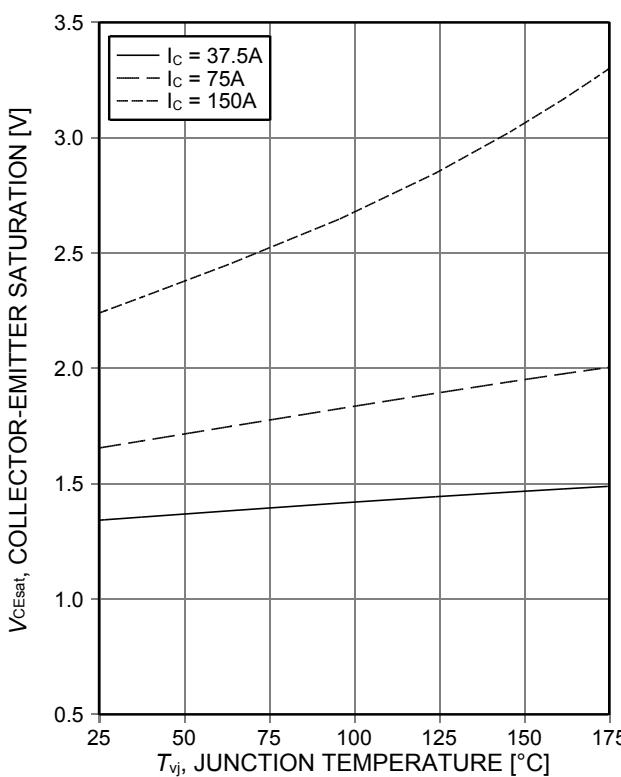


Figure 7. Typical collector-emitter saturation voltage as a function of junction temperature  
( $V_{GE}=15\text{V}$ )

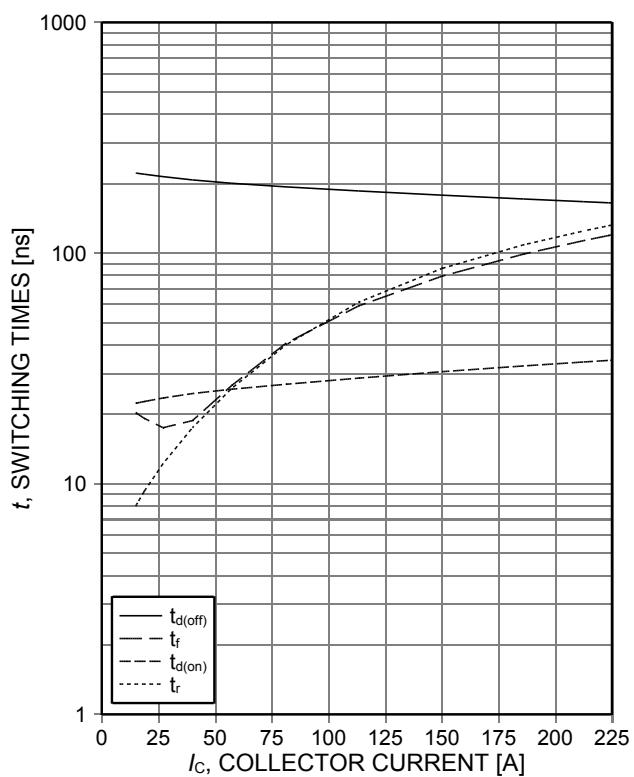
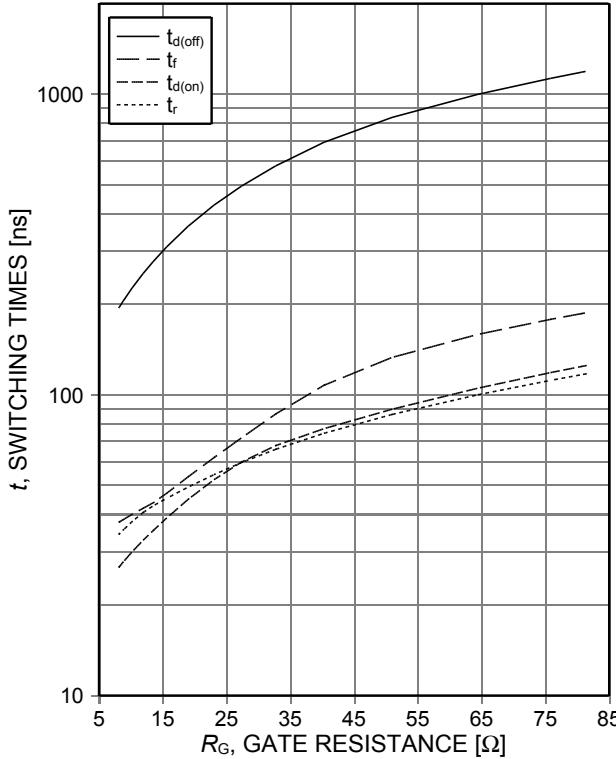
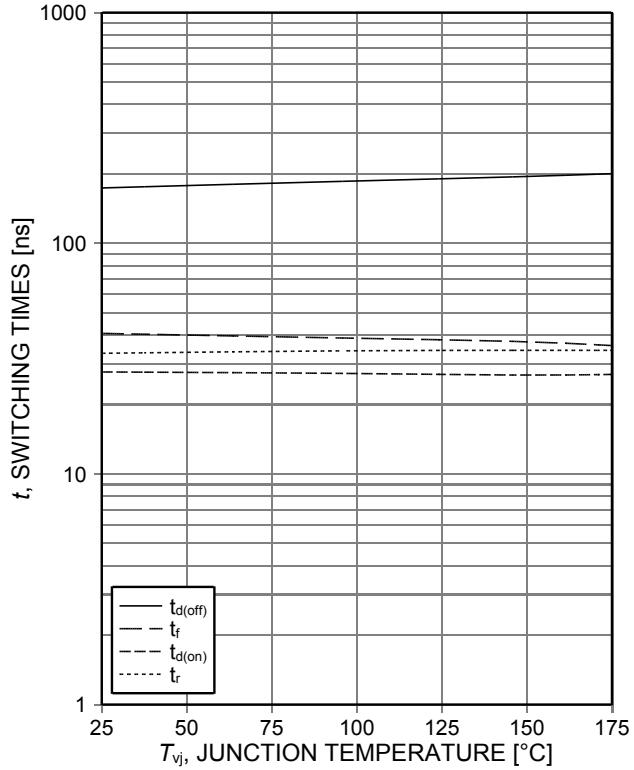


Figure 8. Typical switching times as a function of collector current  
(inductive load,  $T_{vj}=150^{\circ}\text{C}$ ,  $V_{CE}=400\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $R_{G(\text{on})}=8\Omega$ ,  $R_{G(\text{off})}=8\Omega$ , dynamic  
test circuit in Figure E)

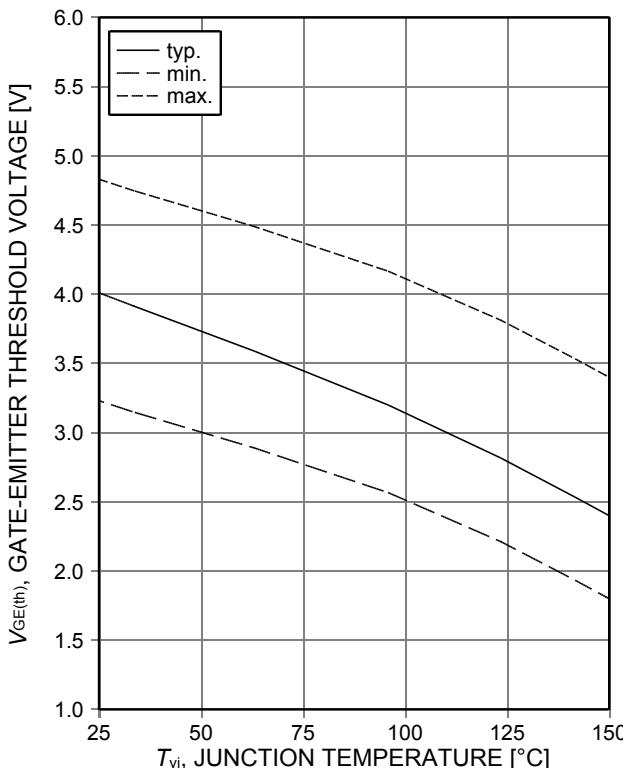
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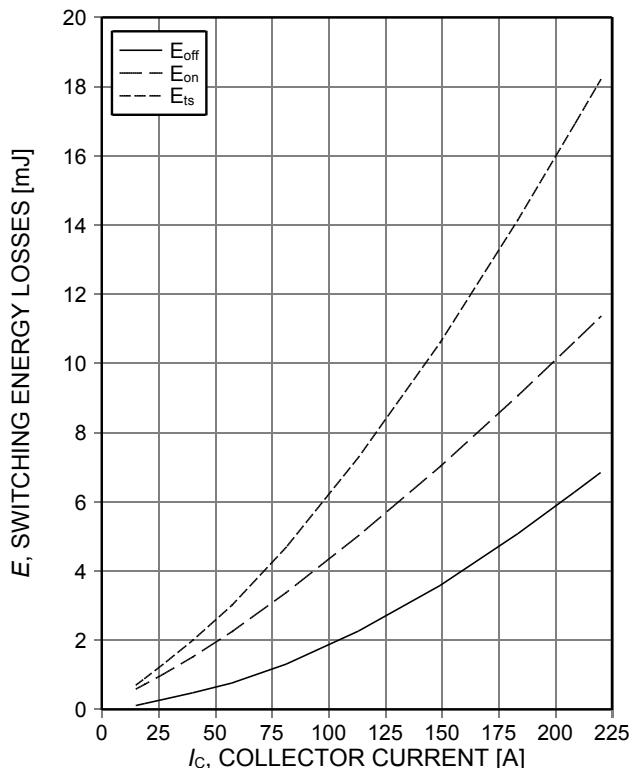
**Figure 9. Typical switching times as a function of gate resistance**  
 (inductive load,  $T_{vj}=150^\circ\text{C}$ ,  $V_{CE}=400\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $I_c=75\text{A}$ , dynamic test circuit in  
 Figure E)



**Figure 10. Typical switching times as a function of junction temperature**  
 (inductive load,  $V_{CE}=400\text{V}$ ,  $V_{GE}=0/15\text{V}$ ,  
 $I_c=75\text{A}$ ,  $R_{G(\text{on})}=8\Omega$ ,  $R_{G(\text{off})}=8\Omega$ , dynamic test  
 circuit in Figure E)



**Figure 11. Gate-emitter threshold voltage as a function of junction temperature**  
 ( $I_c=0.75\text{mA}$ )



**Figure 12. Typical switching energy losses as a function of collector current**  
 (inductive load,  $T_{vj}=150^\circ\text{C}$ ,  $V_{CE}=400\text{V}$ ,  
 $V_{GE}=0/15\text{V}$ ,  $R_{G(\text{on})}=8\Omega$ ,  $R_{G(\text{off})}=8\Omega$ , dynamic  
 test circuit in Figure E)





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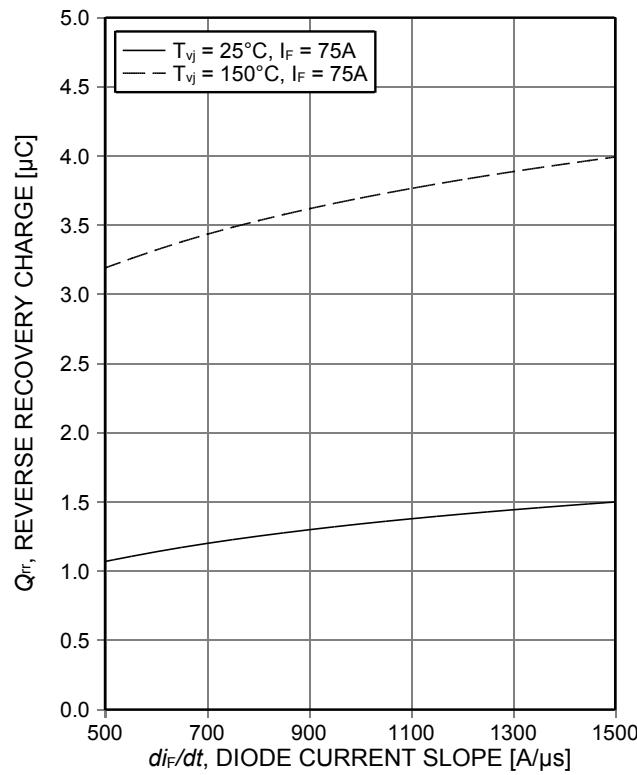


Figure 21. Typical reverse recovery charge as a function of diode current slope ( $V_R=400V$ )

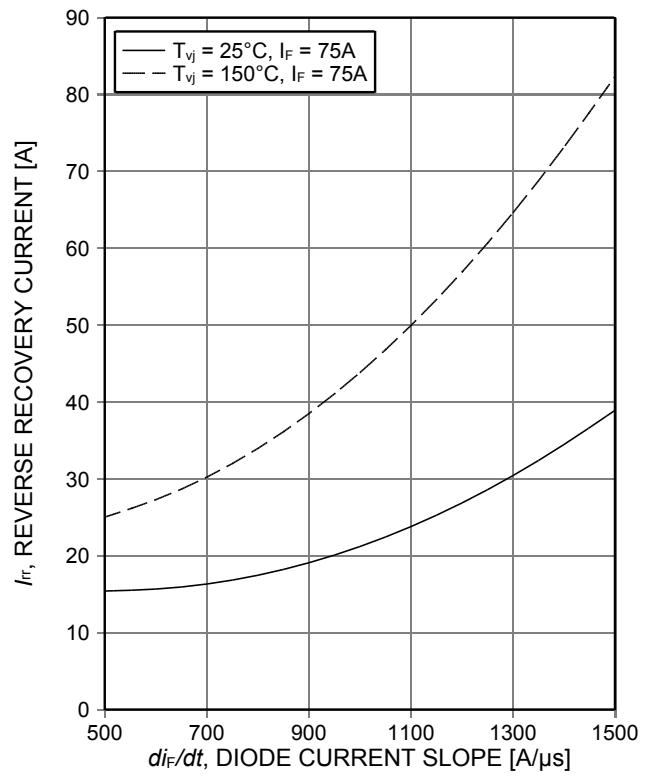


Figure 22. Typical reverse recovery current as a function of diode current slope ( $V_R=400V$ )

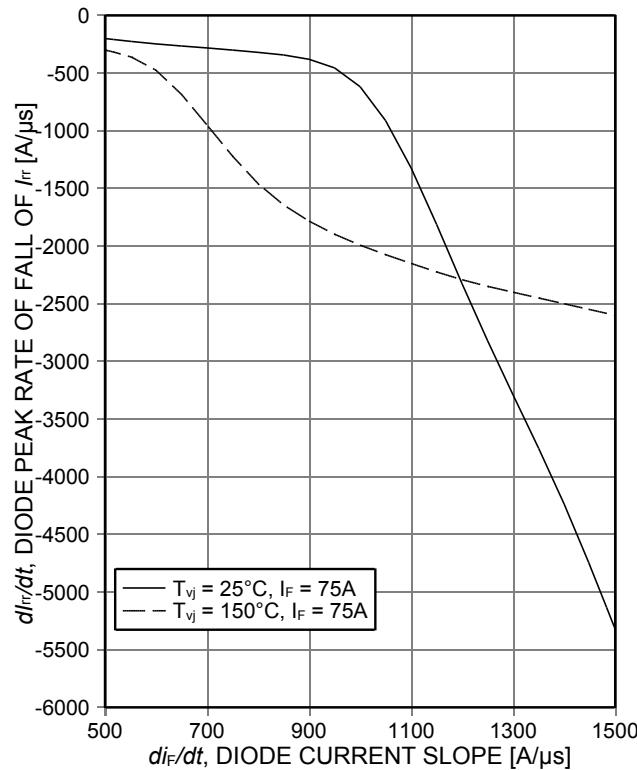


Figure 23. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope ( $V_R=400V$ )

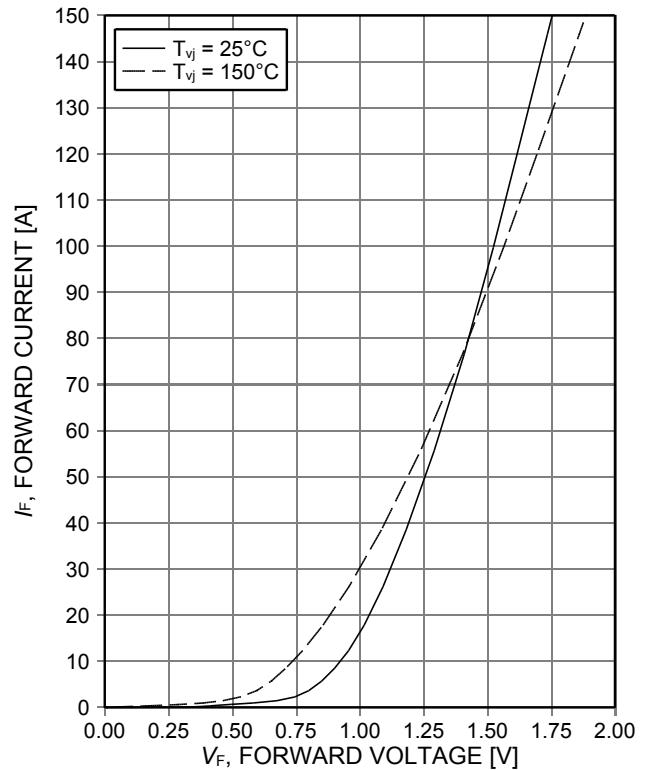


Figure 24. Typical diode forward current as a function of forward voltage

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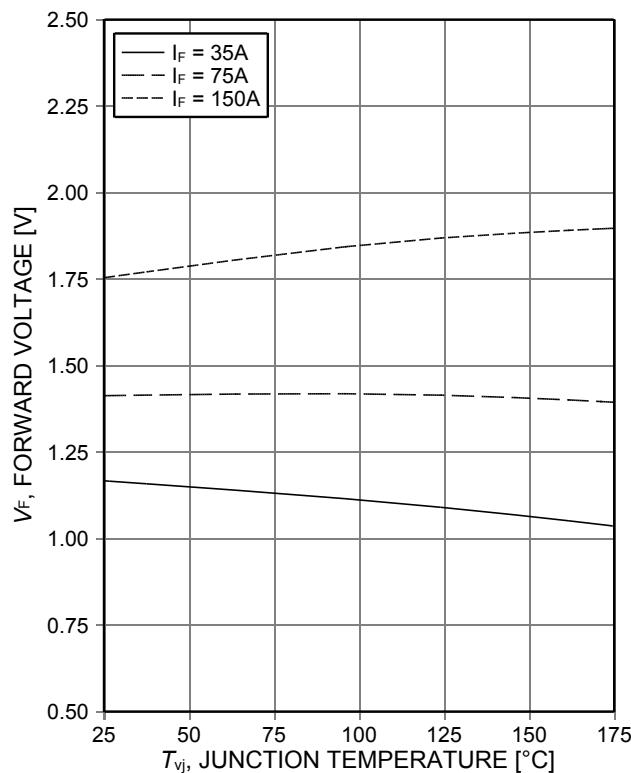


Figure 25. Typical diode forward voltage as a function of junction temperature



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## Testing Conditions

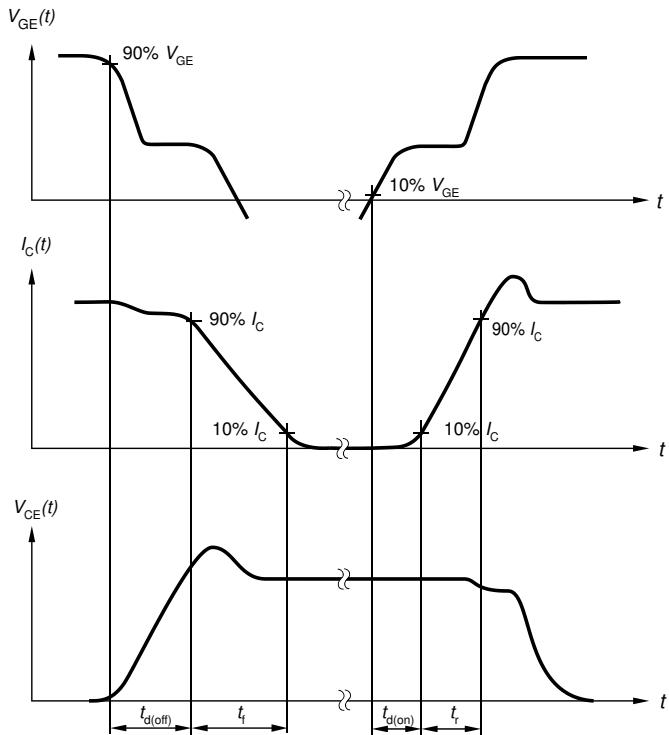


Figure A. Definition of switching times

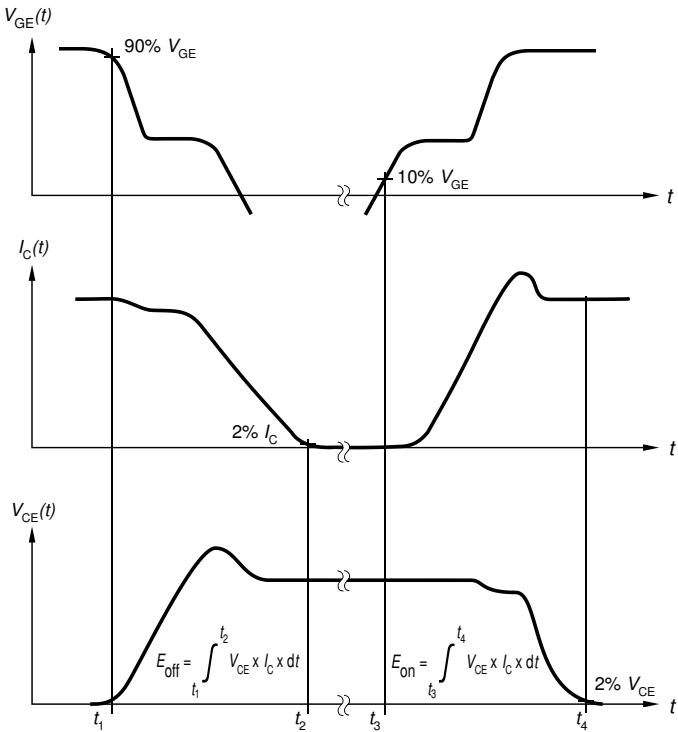


Figure B. Definition of switching losses

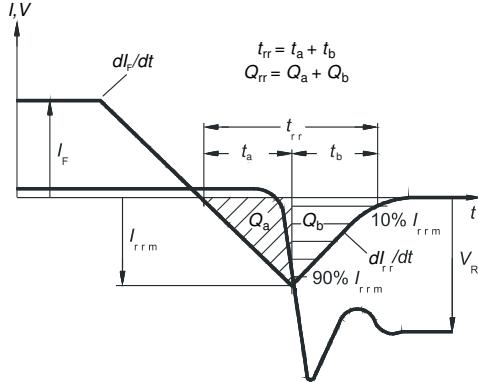


Figure C. Definition of diode switching characteristics

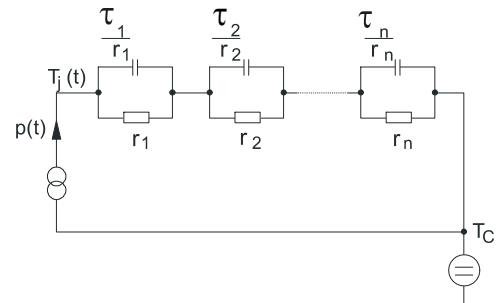


Figure D. Thermal equivalent circuit

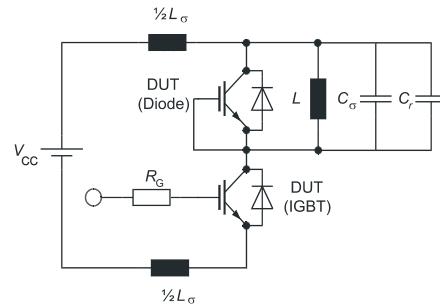


Figure E. Dynamic test circuit  
 Parasitic inductance  $L_\sigma$ ,  
 parasitic capacitor  $C_\sigma$ ,  
 relief capacitor  $C_r$ ,  
 (only for ZVT switching)

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High speed series fifth generation**Revision History**

IKW75N65EH5

**Revision: 2017-07-27, Rev. 2.2**

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.1	2015-05-20	Final data sheet
2.2	2017-07-27	Correction Fig.1

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